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*Dieses Buch gibt eine fundierte Einführung in die Methoden der Qualitäts- und Zuverlässigkeitssicherung bei der Entwicklung und Produktion von Geräten und Systemen. Der Schwerpunkt liegt auf der Anwendung, vor allem auch in Verbindung mit der ISO 9001 und der EU-Produkthaftungsregelungen. Zahlreiche Beispiele, Abbildungen und Tabellen illustrieren die praxisnah aufbereiteten, sauber mathematisch begründeten Inhalte. Dem Leser wird somit ein rascher Einstieg in Theorie und Praxis der Qualitäts- und Zuverlässigkeitssicherung geboten, der auch für das Selbststudium geeignet ist. Das Werk richtet sich sowohl an Entwicklungsingenieure, Projektleiter, Qualitätsfachleute, Produktionsingenieure sowie Ingenieure in Marketing und Vertrieb als auch an Studenten an Fachhochschulen und Universitäten.*

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